S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/445,131	XIE, JIANLEI
Examiner	Art Unit
Joseph Haley	2627

Joseph Haley

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	d interference arch	1/26/2007	JRH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see updated EAST search notes	1/26/2007	JRH	